## NANOSCALE RESEARCH FACILITY (NRF) INDIAN INSTITUTE OF TECHNOLOGY DELHI HAUZ KHAS, NEW DELHI- 110016

Date: Nov. 16, 2012

## **NOTICE INVITING QUOTATIONS**

Ref: No. NRF/UV-LT-PL/2012 **Due date: Dec. 17, 2012** 

Please send your quotations to the undersigned in a sealed cover super scribed with our Ref. no. & due date for the following items (UV low temp Photoluminescence system with multiple options).

S.No.	Name of item with full technical specifications	quantity
1	UV low temp Photoluminescence system for semiconductor thin films and nanostructures:	01
	Excitations source: Xe-arc lamp (450 W) (ozone free, spectral range 300 nm - 1700 nm) along with external cw lasers such as 325 nm He-Cd laser (with variable output power: $\leq$ 5mW to $\geq$ 20 mW) and 514 nm Argon laser (with variable output power: $\leq$ 5mW to $\geq$ 20 mW), cw laser 785 nm (maximum output power: 100 mW); for lamp the excitation range must be continuously tunable within 200 nm $-$ 950 nm. Laser spot size: $\leq$ 1 $\mu m$ Spectral range: $300\text{-}1000$ nm Wavelength accuracy: $\pm 0.25$ nm or better Monochromators: Two (one at source side other at detector side) double grating aberration corrected holographic grating (1800 gr/mm or better), wavelength range: from $\leq$ 200 nm to $\geq$ 1000 nm, resolution 0.05 nm, focal length $\geq$ 500 mm, motorized.	
	Emission detector: TEC cooled ( $\leq$ -70 °C) CCD detector, Pixel: 1024x256, pixel size: 26 $\mu$ m x 26 $\mu$ m, Spectral range: $\leq$ 200 nm to $\geq$ 1000 nm, Quantum optical efficiency $\geq$ 50% between 500 nm to 800 nm, dark noise $\leq$ 0.0025 e-/pixel/sec. Electronics: Data acquisition system must have at least 16 bit DA/AD board with PCI interface, AD sampling $\geq$ 500 kHz.	
	Sample heating/cooling option: Sample temperature should be variable between 5 K to 300 K using closed cycle He cryostat with an set point accuracy of 1K and temperature stability of 0.1 K with a suitable temperature controller.  Sample mapping: Sub-micron mapping of nanostructures (spatial resolution at least 250 nm). The system should able to do spectral mapping at least for 2 inch wafer. All the XYZ stages must be motorized with step resolution of 100 nm and computer controlled.  Sample holders: Our samples will be semiconductors thin film or	

	nanostructures, solid state samples (sample size at least 2 inch diameter and 1 mm thickness); also include cuvett cell holder.  Software: i. Fully functional software for data acquisition and data analysis using a Windows based operating system (Windows XP or later versions).  i. Scientific publication-quality graphics and layout capabilities should be available within the control and analysis software environment  ii. Computer: Windows based operating system with flat panel Monitor (24 inch or larger), 500 GB HDD, CD/DVD writer, USB ports (8), should be able to export files to the clipboard or save as JPEG, PNG, BMP, TIFF etc.	
2	All the required accessories for confocal (10X, 20X and 100X) Raman measurements (both stokes and antistokes); spectral resolution ≤ 1 cm <sup>-1</sup> /pixel in UV and visible.	1
3	Desirable option: Attachment for coupling with Atomic Force Microscopy system should be quoted separately.	1

Quoted price should include all the calibration samples, all the accessories needed for the system, and all the necessary installation and training provided by the vendor. **PL mapping on a semiconductor material should be demonstrable.** A compliance chart is required for all the technical specifications mentioned above. **Users list:** Vendors should provide user list for the said item in India.

**Warranty:** (**Required**) On-site comprehensive including part replacement for 2 years. Additional warranty per annum may be quoted. This should be clearly shown in the technical as well as financial bid.

## Terms and conditions covering submission of quotations

1. **DELIVERY:** All prices quoted for FOB

2. **TERMS OF PAYMENT:** Letter of credit

3. VALIDITY OF QUOTATIONS: three months or more

4. **CORRESPONDENCE:** No correspondence regarding acceptance

/rejection of quotation will be entertained.

5. **SUBMISSION OF QUOTATIONS:** Separate quotations should be submitted

for technical bid and commercial bid in two separate and clearly marked envelopes.

6. **DISCOUNTS/REBATES:** Special discounts/rebate wherever admissible

keeping in the view that supplies are being made

for an Educational institute may be indicated in the

offer.

7. DIRECTOR'S RIGHT:

Director, IIT Delhi reserves the right of acceptance or rejection of any or all quotations without

assigning any reason.

Please specify terms and conditions. The quotations must have a validity of 3 months. Sealed quotations (<u>separate technical and financial</u>) may be send to the following address.

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